

# Using Hidden Semi-Markov Models for Effective Online Failure Prediction

Felix Salfner and Miroslaw Malek

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Presented by: Fahad Arshad

School of Electrical and Computer Engineering  
Purdue University



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## Introduction

- Proactive fault handling requires prediction of *failures*
- Online failure prediction is short-term failure predictions based on the current runtime system's state

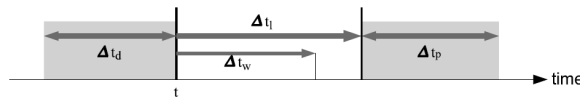


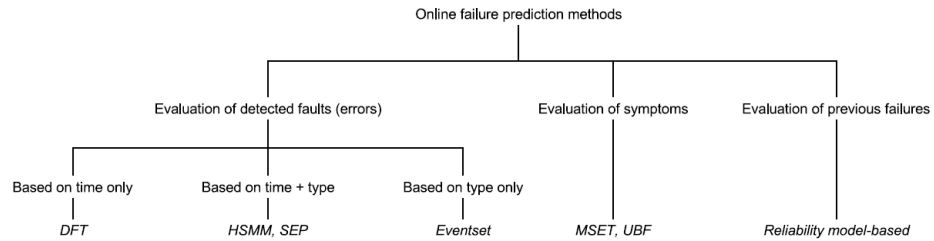
Figure 1. Time relations in online failure prediction:  $t$  – present time;  $\Delta t_l$  – lead time;  $\Delta t_w$  – warning time;  $\Delta t_p$  – prediction period;  $\Delta t_d$  – data window size



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## Classification of Failure prediction Techniques



- Failure prediction based from previous failures is closely related to reliability prediction
- Majority of existing techniques are symptom based
  - Symptoms are side-effects of faults
  - Memory consumption, no of running processes etc.



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## HSMM-based Failure Prediction

- Basic assumption:
  - Failure-prone system behavior can be identified by characteristics patterns of errors.
- Approach
  - Error event timestamps and message IDs form an *error sequence*
  - After some data preprocessing, failure and non-failure error sequences are extracted
  - Two HSMMs are trained: Failure and Non-Failure sequences with parameters  $\lambda_F$  and  $\lambda_{F'}$ .



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## HSMM-based Failure Prediction

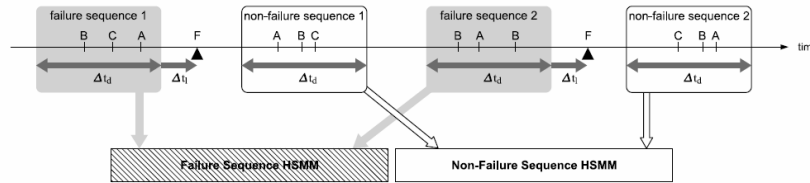


Figure 3. Two HSMMs are trained: One for failure sequences and one for non-failure sequences. Sequences consist of errors A, B, or C that have occurred in previously recorded training data. Failure sequences consist of errors that occurred within a time window of length  $\Delta t_d$  preceding a failure ( $\blacktriangle$ ) by lead time  $\Delta t_l$ . Non-failure sequences consist of errors that occurred at times when no failure was imminent.



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## HSMM-based Failure Prediction

- The goal is to assess, whether a given an error sequence  $\mathbf{o} = [o_0 \dots o_L]$  is failure prone or not
- Sequence likelihood  $P(\mathbf{o}|\lambda)$ 
  - Probability that a given model  $\lambda$  can generate observation sequence  $\mathbf{o}$
  - Sequence likelihood is computed for both models

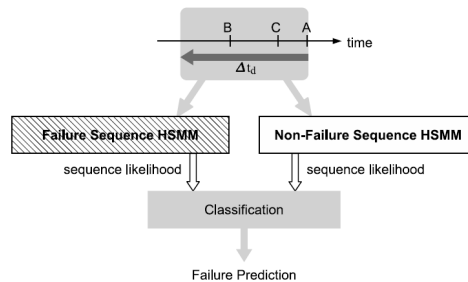


Figure 4. Online failure prediction. At the occurrence of error A (present time), the sequence under investigation consists of all errors that have occurred within the preceding time window of length  $\Delta t_d$ . Failure prediction is performed by computing sequence likelihood of the sequence using both the failure and non-failure model. Both likelihoods are evaluated using Bayes decision theory for classification as failure-prone or failure-free



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## HSMM-based Failure Prediction

- Criteria for classification:
  - Classify sequence  $\mathbf{o}$  as failure-prone, iff

$$\log [P(\mathbf{o} | \lambda_F)] - \log [P(\mathbf{o} | \lambda_{\bar{F}})] > \underbrace{\log \left[ \frac{c_{\bar{F}F} - c_{\bar{F}\bar{F}}}{c_{F\bar{F}} - c_{FF}} \right]}_{\in (-\infty; \infty)} + \underbrace{\log \left[ \frac{P(\bar{F})}{P(F)} \right]}_{const.}$$

- $c_{ta}$  denotes the associated cost for assigning a sequence of type  $t$  to class  $a$ ,
  - e.g.,  $c_{F\bar{F}}$  denotes the cost for falsely classifying a failure-prone sequence as failure free.
- $P(F)$  and  $P(\bar{F})$  denote class probabilities of failure and non-failure sequences, respectively



## Reliability-based prediction

- A simple reliability model is represented by an exponential distribution and is used for comparison

$$F(t) = 1 - e^{-\lambda t}$$

- $F(t)$  denotes the probability of a failure until time  $t$  and  $R(t)$  denotes reliability
- Failure rate is set to the inverse of mean-time-to-failure (MTTF)
- A failure is predicted according to the median of the distribution.
- After each failure that occurs in the test data set, the timer is reset and prediction starts again.



## Dispersion Frame Technique (DFT)

- A Dispersion Frame (DF) is the interval time between successive error events
- The Error Dispersion Index (EDI) is defined to be the number of error occurrences in the later half of a DF
- A failure is predicted if one of five heuristic rules fires
  - one rule puts a threshold on error-occurrence frequencies
  - another on window-averaged occurrence frequency



## Dispersion Frame Technique (DFT)

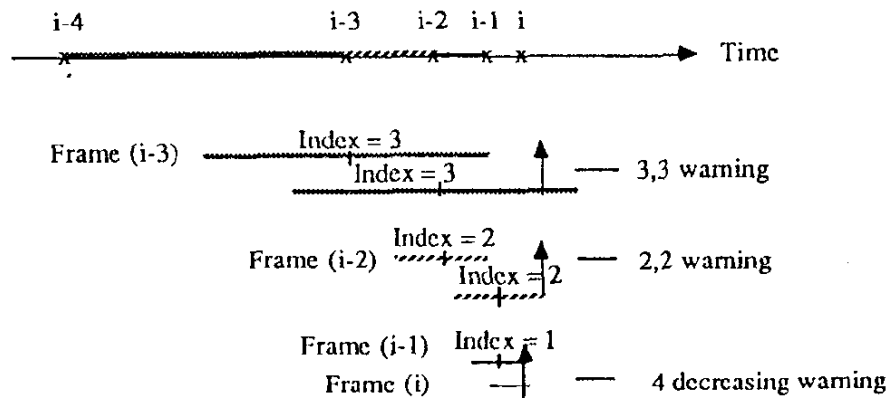


Figure 3. Dispersion Technique



## Eventset-based Method

- This method is based on a set of events (errors) preceding a target event (failure).
- The goal is to set up a rule-based failure prediction system containing a database of indicative eventsets
- For each error, current set of events  $Z$  is formed from all errors that have occurred within  $\Delta t_d$  before present time.
- Database  $DB$  of indicative eventsets is then checked whether  $Z$  is a subset of any  $D \in DB$ . If so, a failure warning is raised at time  $\Delta t_l$  in the future.



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## Eventset-based Method

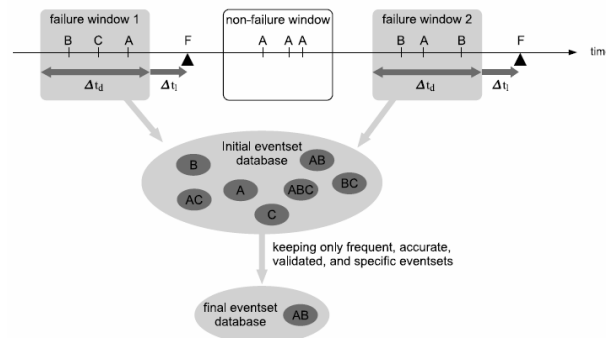


Figure 6. Eventset-based method. An eventset is the set of error types that have occurred within a time window of length  $\Delta t_d$  preceding a failure ( $\blacktriangle$ ) by lead time  $\Delta t_l$



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## Experiment Description

- The prediction techniques are applied to a commercial telecommunication system
- Failure definition:
  - An event such that for a non-overlapping five minute intervals, the fraction of calls having response time longer than 250ms exceeds 0.01%
- Metrics
  - *Precision*: fraction of correctly predicted failures in comparison to all failure warnings
  - *Recall*: fraction of correctly predicted failures in comparison to the total number of failures.
  - *F-Measure*: harmonic mean of precision and recall
  - *False positive rate*: fraction of false alarms in comparison to all non-failures.



## Contingency Table and Metrics formulas

		Truth	
		Failure	Non-failure
Predicted	Failure	True positive (TP)	False positive (FP)
	Non-Failure	False negative (FN)	True negative (TN)

(a)

Metric	Formula
precision	$p = \frac{TP}{TP+FP}$
recall=true positive rate	$r = tpr = \frac{TP}{TP+FN}$
false positive rate	$fpr = \frac{FP}{FP+TN}$
F-measure	$F = \frac{2 * p * r}{p+r}$

(b)

**Figure 8. Contingency table (a) and definition of metrics (b)**



## Results

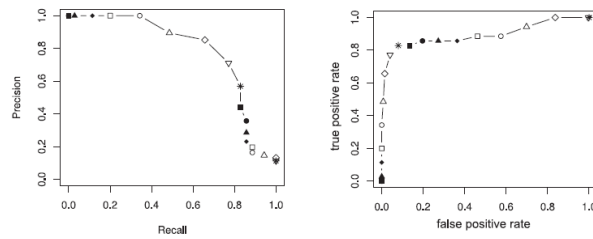


Figure 12. Prediction performance of the HSMM approach. precision-recall plot (left) and ROC curve (right). The various symbols denote different classification threshold values

Prediction technique	Precision	Recall	F-Measure	FPR
reliability-based	0.214	0.154	0.1791	n/a
DFT	0.314	0.458	0.3729	0.0027
Eventset	0.242	0.917	0.3826	0.1068
HSMM (max. F-measure)	0.852	0.657	0.7419	0.0145

Figure 13. Summary of prediction results



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## Conclusion

- A new approach to online failure prediction that forecasts failures by recognition of failure-prone patterns of error events
- The approach allows to employ a customizable threshold by which the tradeoff between, e.g., precision and recall can be controlled.
- HSMM gives better prediction performance in comparison to reliability based prediction, DFT and eventset based method



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